Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | WU ET AL. | Examiner | Art Unit | Truc T. T. Nguyen | 2833 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,589,075	07-2003	Wu, Wen-Chang	439/550
	В	US-5,984,721	11-1999	Self et al.	439/546
	С	US-5,120,231	06-1992	Masumoto, Yoshihide	439/76.1
	D	US-6,540,385	04-2003	Ikeda et al.	362/512
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			- "
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	S					·
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.